## The Stochastic Modeling of $\mathrm{TiO}_{2}$ Memristor and Its Usage in Neuromorphic System Design

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## Outline

- Neural network and memristor
- Gaps between previous memristor models and real devices
- Continuous and arbitrary states vs. binary or multi-level states
- Deterministic vs. stochastic
- Stochastic modeling of $\mathrm{TiO}_{2}$ memristor
- ON and OFF static states
- Dynamic switching process
- Neuromorphic applications
- Weight storage unit
- Stochastic neuron
- Conclusion and future work


## Neural Network: Abstract of Bio Systems



## Neural network for pattern recognition:

- Training: Learn from different prototype patterns.
- Recognize: Output the most-likely prototype pattern for a given input.


## Memristor - Rebirth of Analog Approach



Natural weight carriers:

- Non-volatility, high density
- Analog resistance states
- Two terminal programming

Memristor Crossbar


$$
\mathbf{I}=\mathbf{V}_{\mathbf{M} 1} / \mathbf{M} 1+\mathbf{V}_{\mathbf{M} 2} / \mathbf{M}_{2}+\ldots+\mathbf{V}_{\mathbf{M n}} / \mathbf{M}_{\mathrm{n}}
$$

- Natural weight summation
- MIMO ~ avoid reading sneak path
- Cost ~ O(N), not O(N²)


## Observation 1

It's difficult to precisely tune the state of every memristor in a large crossbar array.


Sneak paths causes unexpected state changing on neighbor devices.


Wire resistance results in voltage degradation, especially on the device far from the driver.

## Observation 2

- Metal oxide based memristors behave stochastically.
- The stochastic feature is missing in existing physical models.
- Modeling the stochastic feature which is heavily correlated with variations is very difficult.
- Previous statistical analyses ${ }^{[1]}$ consider only the binary switching, while ignoring memristor's continuous analog states.



## A general model:

$$
\begin{aligned}
V & =I \cdot M(w, V) \\
\frac{d w}{d t} & =f(w, V)
\end{aligned}
$$

[1] G. Medeiros-Ribeiro, et al., Nanotechnology, 2011.


## Stochastic Modeling of $\mathrm{TiO}_{2}$ Memristor

- A stochastic behavior model of $\mathrm{TiO}_{2}$ memristor was firstly proposed in this work.
- The model bypasses material-related parameters by directly linking the device analog behavior to stochastic functions.
- Simpler configuration: no need to decouple the impact of variations
- Simpler device model: feasible to used in large-scale simulations.
- Better fitting the stochastic nature: more statistically accurate.


## Model Construction - Static States

- The Lognormal fitting is used for ON and OFF states of $\mathrm{TiO}_{2}$ memristor ${ }^{[2]}$.
- The internal variable $w$ follows a normal distribution.
- The device resistance has an exponential relation with $w$.

$$
\text { [2] W. Yi, et al., Appl. Phys. A, } 2011 .
$$




## Model Construction - Dynamic Switching

The stochastic switching process is illustrated as below.


## Analog Switching Process

- The time dependency of switching probability can be approximated by the cumulative probability function (CDF) of lognormal distribution ${ }^{[1]}$.

$$
P(\text { Success switch })=F\left(t_{\text {switch }} ; \mu_{t}, \sigma_{t}\right)=\frac{1}{2} \operatorname{erfc}\left[-\frac{\left(\ln t_{\text {switch }} / \mu_{t}\right)^{2}}{\sqrt{2} \sigma_{t}{ }^{2}}\right]
$$

[1] G. Medeiros-Ribeiro, et al., Nanotechnology, 2011.

- We further expend it to fit analog process:

$$
\begin{aligned}
& \frac{d P(\text { Success switch })}{d t_{\text {switch }}}=f_{t_{\text {switch }}}\left(t_{\text {switch }} ; \mu_{t}, \sigma_{t}\right) \\
& \frac{d R}{d t}=\left(R_{\text {off }}-R_{\mathrm{on}}\right) \cdot f_{t_{\text {switch }}}\left(t_{\text {switch }} ; \mu_{t}, \sigma_{t}\right)
\end{aligned}
$$

## Over-Tune

- The device mechanism is different in over-tune situation.
- Considering the slow and relatively small resistance changing in over-tune situation, a linear approximation is adopted in which $e$ is a fitting parameter:

$$
\mu_{\mathrm{shift}}=e \cdot q=e \cdot\left(\frac{V}{M}\right) \cdot t
$$

## Model Verification

Example of 100 cycles


ON switching fitting


Static states fitting


OFF switching fitting


## Neuromorphic Applications

- Our primary interest is to effectively utilize memristive switches and provide feasible designs for NN hardware.
- Continuous weight storage unit
- Alleviating the impact of stochastic
- Using binary states of memristor to represent continuous value
- Stochastic neuron
- Making use of stochastic feature
- Replacing pseudo-random number generators in traditional NN hardware


## Continuous Weight Storage Unit

- Distribution of parallel connected memristors
- An example consisting of 9 parallel connected memristors


Number of ON state memristive switches

## Continuous Weight Storage Unit

- A macro cell
- Containing multiple memristive switches in crossbar structure.
- A larger memristive switch crossbar can be partitioned into many macro cells for continuous weight storage.



## Feedback Switching Scheme

- Step 1: Decide the number of ON state memristors in a macro cell.
- Step 2: Switch memristors and detect conductance of macro cell.
- Step 3: Repeat Step 2 until conductance falls in acceptable range.

Average case


Worst case


## Stochastic Neuron

- Unlike weight storage, stochastic neuron employs the stochastic feature of memristor:
- The probability of output states depends on the input voltage.



## Stochastic neuron

Binary neuron



## Continuous neuron



## Conclusion

- A simple and statistically accurate stochastic memristor model is firstly proposed.
- Two fundamental NN components are designed and analyzed by leveraging the proposed model.
- The weight storage unit:
- Uses multiple devices to obtain the continuous analog state while bypassing complex tuning scheme.
- On average, an analog value can be obtained within 25 attempts.
- Stochastic neuron:
- Simple design structure by leverage the stochastic feature of memristors.
- The neuron's stochastic function is determined by the device characteristics.


# Thank you for attending my presentation! 

## Questions are welcome!

